

# **TQTHDB12310**

Thyristors Solid Protection Device Bidirectional transient voltage suppressors

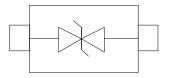
#### Description

The TQTHDB12310 is designed with TECH CHIP Punch-Through process TVS technology to protect voltage sensitive components from ESD. Excellent clamping capability, low leakage, and fast response time provide best in class protection on designs that are exposed to ESD. Because of its small size, it is suited for use in cellular phones, MP3 players, digital cameras and many other portable applications where board space comes at a premium. Also because of its low capacitance, it is suited for use in high frequency designs such as USB 2.0 high speed, USB 3.0 super speed, VGA, DVI, HDMI, ESATA and other high speed line applications.

#### Features

- For surface mounted applications to optimize board space
- Low profile package
- > Bidirectional crowbar protection
- ➤ Low leakage current : I = 5uA max
- ➤ Low on-state voltage
- ➤ Low Capacitance
- ➤ Response Time is < 1us
- > YD/T 950 IEC 61000-4-5
- > Solid-state silicon technology
- ➤ Meets MSL 1 Requirements
- > ROHS compliant

#### • PIN configuration



**SMB** 

### Applications

- ➤ Hand-Held Portable Applications
- Networking and Telecom (Ethernet 10/100/1000 Base T)
- USB Interface
- Automotive Electronics
- Serial and Parallel Ports
- Notebooks, Desktops, Servers

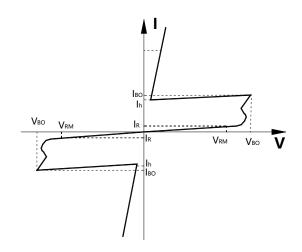
#### Machanical data

- Lead finish: 100% matte Sn(Tin)
- ➤ Mounting position: Any
- Qualified max reflow temperature:260°C
- ➤ Device meets MSL 1 requirements
- Pure tin plating:  $7 \sim 17$  um
- ➤ Pin flatness:≤3mil



#### • Electronic Parameter

Symbol	Parameter		
$V_{RM}$	Stand-off voltage		
$V_{BR}$	Breakdown voltage		
$V_{BO}$	Switching Voltage		
$I_{BO}$	Breakover current		
$I_{RM}$	Leakage current at V <sub>RM</sub>		
$I_{PP}$	Peak pulse current		
$I_{\mathrm{H}}$	Holding current		
V <sub>T</sub>	On-state Voltage at I <sub>T</sub>		
Co	Off-state Capacitance		



# • Absolute maximum rating @TA=25℃

Parameter	Symbol	Value	Unit	
	10/1000 us		100	A
Non nonetitive meet pulse comment	10/560 us	т.	150	
Non-repetitive peak pulse current	5/310 us	$I_{PP}$	150	
	8/20 us		400	
Non-repetitive peak pulse voltage 10/700us		$V_{PP}$	6000	V
ESD Rating per IEC61000-4-2: Cor	$ m V_{ESD}$	8	KV	
Ai		15		
Storage temperature range	Ts	-40 to +150	${\mathbb C}$	
Maximum junction temperature	Tj	150	$^{\circ}$	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

<sup>\*</sup>Other voltages may be available upon request.

### • Electrical Characteristics @TA=25°C

	$V_{RM}$	$I_{RM}$	V <sub>BO</sub>	I <sub>BO</sub>	$V_{T}$	I <sub>T</sub>	Co	I <sub>H</sub>
Type	Min.	Ma	ax.	Max.	М	ax.	Тур.	Тур.
	V	μА	V	mA	V	A	pF	mA
TQTHDB12310	275	5	350	800	4	2.2	35	150

# • Typical Performance Characteristics

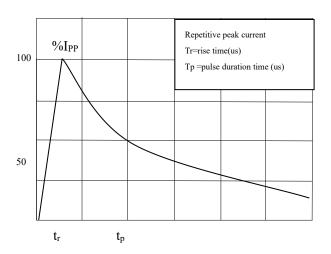


Fig.1 Pulse Waveform (5/310us)

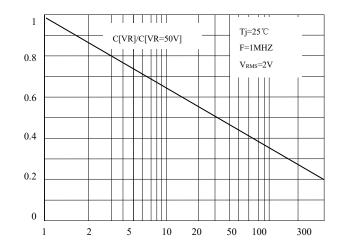


Fig. 2 Relation Variation Of Junction Capacitance

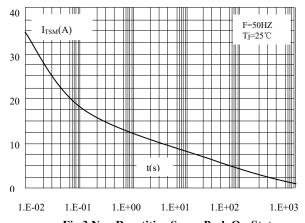


Fig.3 Non Repetitive Surge Peek On-State Current Versus Overload Duration

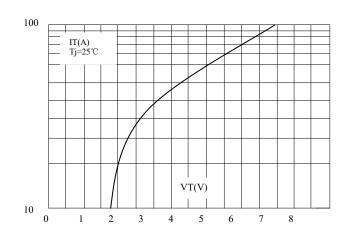


Fig.4 On-State Voltage Versus On-State Current (Typical Values)



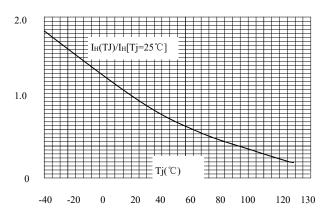


Fig.5 Relative Variation Of Hold Current Versus Junction Temperature

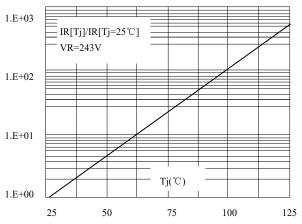


Fig.7 Relative Variation Of Leakage Current Versus Reverse Voltage (Typical Values)

#### • Solder Reflow Recommendation

Peak Temp=257°C, Ramp Rate=0.802deg. °C/sec

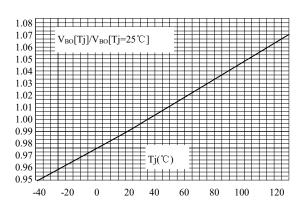


Fig.6 Relative Variation Of Break Over Voltage Versus Junction Temperature

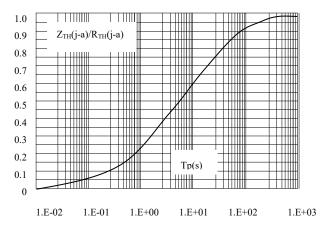
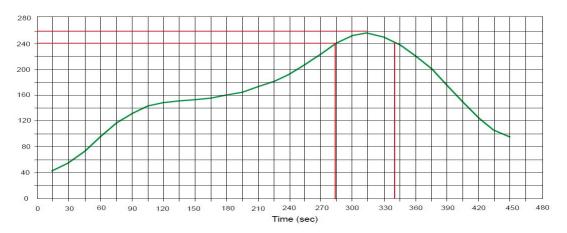


Fig.8 Variation Of Thermal Impedance Junction To Ambient Versus Pulse Duration



# **TQTHDB12310**



# Package Information

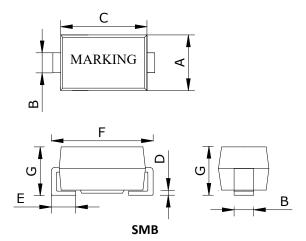
# **Ordering information**

Device	ice Marking Qty per Reel		Reel Size	
TQTHDB12310	P31C	2500	13Inch	

### **Mechanical Data**

Case: SMB

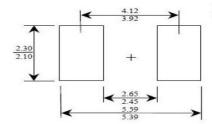
Case Material: Molded Plastic. UL Flammability



DIM	Millimeters				
	Min	Nom	Max		
A	3.30	3.60	3.94		
В	1.80	2.00	2.21		
С	4.05	4.45	5.30		
D	0.051	0.20	0.203		
E	0.76	1.14	1.52		
F	5.08	5.25	5.59		
G	2.05	2.30	2.45		

# **Recommended Pad outline**





#### **DISCLAIMER**

TECH CHIP RE SERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. TECH CHIP DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICIENCE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

THE GRAPHS PROVIDED IN THIS DOCUMENT ARE STATISTICAL SUMMARIES BASED ON A LIMITED NUMBER OF SAMPLES AND ARE PROVIDED FOR INFORMATIONAL PURPOSE ONLY. THE PERFORMANCE CHARACTERISTICS LISTED IN THEM ARE NOT TESTED OR GUARANTEED. IN SOME GRAPHS, THE DATA PRESENTED MAY BE OUTSIDE THE SPECIFIED OPERATING RANGE (E.G., OUTSIDE SPECIFIED POWER SUPPLY RANGE ) AND THEREFORE OUTSIDE THE WARRANTED RANGE.